CIPOS™ Tiny IPM 600V/6A

IM393-S6FP

Description

IM393-S6FP is a 6A, 600V Integrated Power Hybrid IC with Open Emitter pins for advanced Appliance Motor Drives applications such as energy efficient fan and pumps. Infineon's technology offers an extremely compact, high performance AC motor-driver in a single isolated package to simplify design.

This advanced IPM is a combination of Infineon's newest low VCE(on) Trench IGBT technology optimized for best trade-off between conduction and switching losses and the industry benchmark 3 phase high voltage, high speed driver (3.3V compatible) in a fully isolated thermally enhanced package. A built-in high precision temperature monitor and over-current protection feature, along with the short-circuit rated IGBTs and integrated under-voltage lockout function, deliver high level of protection and fail-safe operation. Using a single in line package with full transfer mold structure resolves isolation problems to heatsink.

Features

- Integrated gate drivers and bootstrap function
- Temperature monitor
- Protection shutdown pin
- Low VCE (on) Trench IGBT technology
- Under voltage lockout for all channels
- Matched propagation delay for all channels
- 3.3V Schmitt-triggered input logic
- Cross-conduction prevention logic
- Isolation 2000V_{RMS} min and CTI > 600
- Recognized by UL (File Number : E314539)

Tiny SIP
IM393-S6FP

Potential applications

- Washing machines
- Air-conditioners
- Refrigerators
- Fans
- Dishwashers
- Low power motor drives

Product validation

Qualified for industrial applications according to the relevant tests of JEDEC47/20/22.

Table1 Part Ordering Table

Base part number	Package Type	Standard Pack	
		Form	Quantity
IM393-S6FP	SIP 34x15	36 Tubes	540

Table of Contents

1 Internal Electrical Schematic

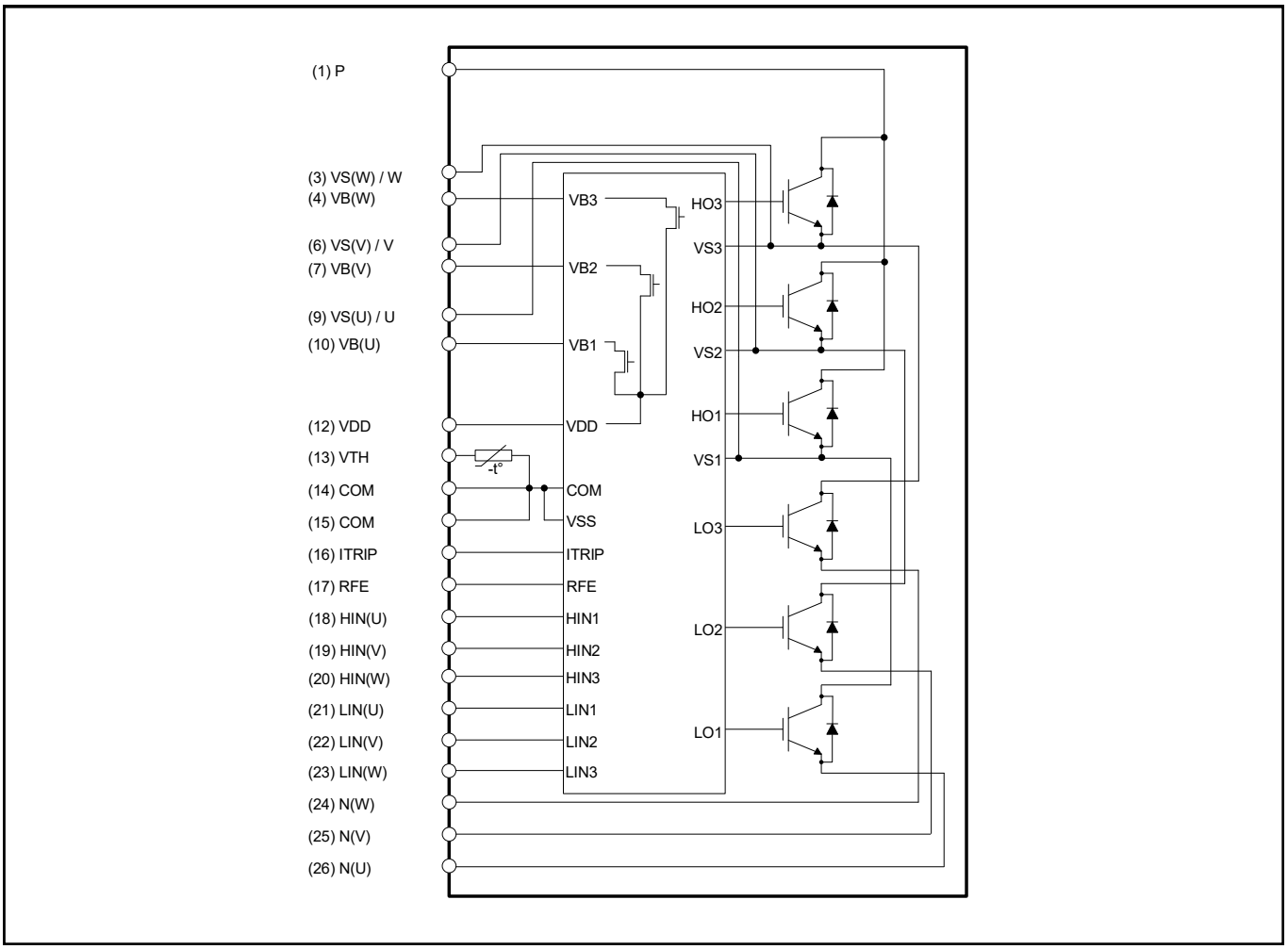


Figure 1 Internal electrical schematic

2 Pin Configuration

2.1 Pin Assignment

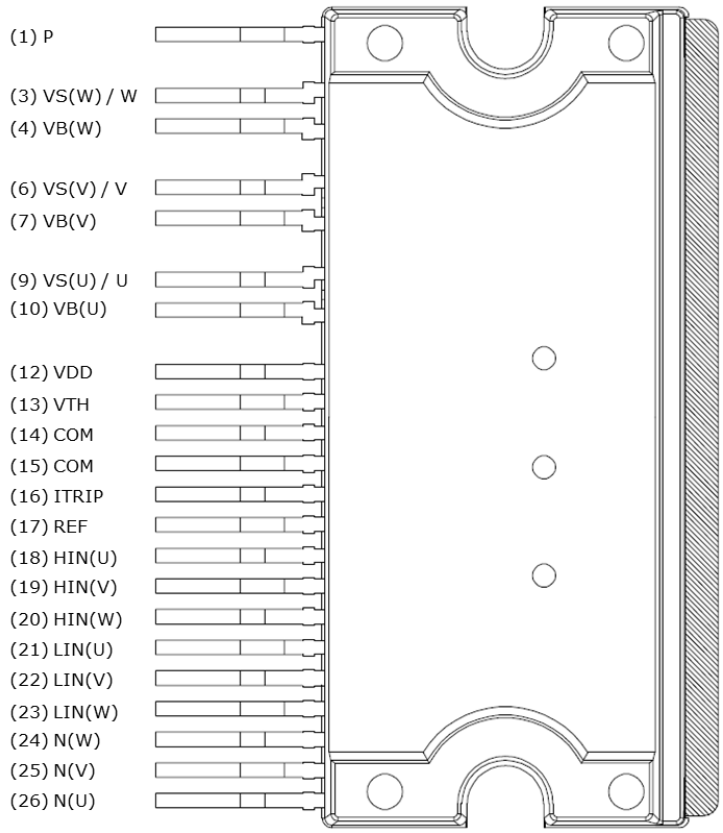


Figure 2 Pin configuration

Table 2 Pin Assignment

Pin	Name	Description
1	P	Positive bus input voltage
(2)	N/A	None
3	VS(W) / W	W-phase high side floating supply offset voltage / W-phase output
4	VB(W)	W-phase high side floating supply voltage
(5)	N/A	None
6	VS(V) / V	V-phase high side floating supply offset voltage / V-phase output
7	VB(V)	V-phase high side floating supply voltage
(8)	N/A	None
9	VS(U) / U	U-phase high side floating supply offset voltage / U-phase output
10	VB(U)	U-phase high side floating supply voltage
(11)	N/A	None
12	VDD	Low side control supply
13	VTH	Temperature monitor
14	COM	Low side control negative supply
15	COM	Low side control negative supply
16	ITRIP	Over current protection input
17	RFE	RCIN / Fault / Enable
18	HIN(U)	U-phase high side gate driver input
19	HIN(V)	V-phase high side gate driver input
20	HIN(W)	W-phase high side gate driver input
21	LIN(U)	U-phase low side gate driver input
22	LIN(V)	V-phase low side gate driver input
23	LIN(W)	W-phase low side gate driver input
24	N(W)	W-phase low side emitter
25	N(V)	V-phase low side emitter
26	N(U)	U-phase low side emitter

2.2 Pin Descriptions

HIN(U,V,W) and LIN(U,V,W) (Low side and high side control pins)

These pins are positive logic and they are responsible for the control of the integrated IGBT. The Schmitt-trigger input thresholds of them are such to guarantee LSTTL and CMOS compatibility down to 3.3V controller outputs.

Pull-down resistor of about 4kΩ is internally provided to pre-bias inputs during supply start-up and an ESD diode is provided for pin protection purposes. Input Schmitt-trigger and noise filter provide beneficial noise rejection to short input pulses.

The noise filter suppresses control pulses which are below the filter time T_{FILIN}. The filter acts according to Figure 4.

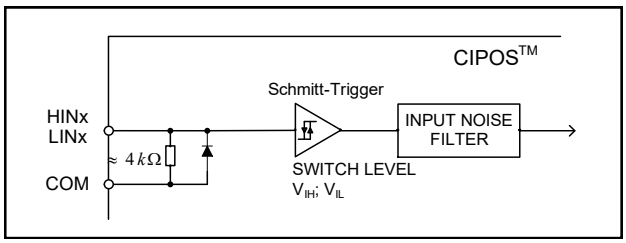


Figure 3 Input pin structure

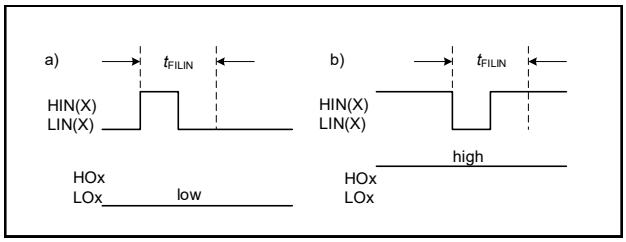


Figure 4 Input filter timing diagram

The integrated gate drive provides additionally a shoot through prevention capability which avoids the simultaneous on-state of the high-side and low-side switch of the same inverter phase. A minimum dead time insertion of typically 275ns is also provided by driver IC, in order to reduce cross-conduction of the external power switches .

V_{DD}, COM (Low side control supply and reference

V_{DD} is the control supply and it provides power both to input logic and to output power stage. Input logic is referenced to COM ground.

The under-voltage circuit enables the device to operate at power on when a supply voltage of at least a typical voltage of V_{DDUV+} = 10.4V is present.

The IC shuts down all the gate drivers power outputs, when the VDD supply voltage is below V_{DDUV-} = 9.4V. This prevents the external power switches from critically low gate voltage levels during on-state and therefore from excessive power dissipation.

$V_{B(U,V,W)}$ and $V_{S(U,V,W)}$ (High side supplies)

V_B to V_S is the high side supply voltage. The high side circuit can float with respect to COM following the external high side power device emitter voltage.

Due to the low power consumption, the floating driver stage is supplied by integrated bootstrap circuit.

The under-voltage detection operates with a rising supply threshold of typical V_{BSUV+} = 10.41V and a falling threshold of V_{BSUV-} = 9.4V.

$V_{S(U,V,W)}$ provide a high robustness against negative voltage in respect of COM. This ensures very stable designs even under rough conditions.

N (U, V, W) (Low side emitters)

The low side emitters are available for current measurements of each phase leg. It is recommended to keep the connection to pin COM as short as possible in order to avoid unnecessary inductive voltage drops.

VTH (Thermistor)

A UL certified NTC is integrated in the module with one terminal of the chip connected to COM and the other to VTH. When pulled up to a rail voltage such as VDD or 3.3V by a resistor, the VTH pin provides an analog voltage signal corresponding to the temperature of the thermistor

RFE (RCIN / Fault / Enable)

The RFE pin combines 3 functions in one pin: RCIN or RC-network based programmable fault clear timer, fault output and enable input.

The RFE pin is normally connected to an RC network on the PCB per the schematic in Figure 5. Under normal operating conditions, R_{RCIN} pulls the RFE pin to 3.3V, thus enabling all the functions in the IPM. The microcontroller can pull this pin low to disable the IPM functionality. This is is the Enable function.

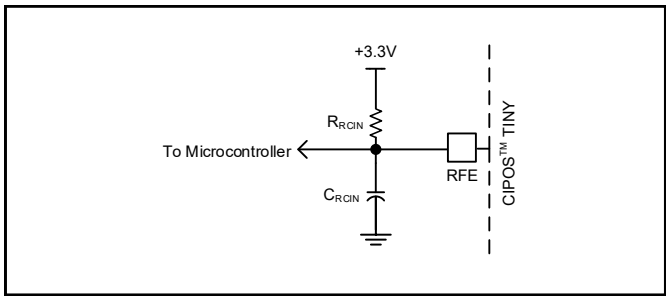


Figure 5 Typical PCB circuit connected to the RFE pin

The Fault function allows the IPM to report a Fault condition to the microcontroller by pulling the RFE pin low in one of two situations. The first is an under-voltage condition on V_{DD} and the second is when the ITRIP pin sees a voltage rising above $V_{IT,TH+}$.

The programmable fault clear timer function provides a means of automatically re-enabling the module operation a preset amount of time ($T_{FLT-CLR}$) after the fault condition has disappeared. Figure 6 shows the RFE-related circuit block diagram inside the IPM .

The length of TFLT-CLR can be determined by using the formula below.

$V_{RFE}(t) = 3.3V * (1 – e^{-t/RC})$

$T_{FLT-CLR} = -R_{RCIN} * C_{RCIN} * \ln(1\text{-}VIN,TH+/3.3V)$

For example, if R_{RCIN} is 1.2MΩ and C_{RCIN} is 1nF, the $T_{FLT-CLR}$ is about 1.7ms with $V_{IN,TH+}$ of 2.5V. It is also important to note that C_{RCIN} needs to be minimized in order to make sure it is fully discharged in case of over current event.

Since the ITRIP pin has a 350ns input filter, it is appropriate to ensure that C_{RCIN} will be discharged below $V_{IN,TH-}$ by the open-drain MOSFET, after 350ns. Therefore, the max C_{RCIN} can be calculated as:

$V_{RFE}(t) = 3.3V * e^{-t/RC} < V_{IN,TH-}$

$C_{RCIN} < 350ns / (- \ln (V_{IN,TH-} / 3.3V) * R_{RFE\_ON})$

Consider $V_{IN,TH-}$ of 0.8V and R_{RFE_ON} of 50ohm, C_{RCIN} should be less than 4.9nF. It is also suggested to use a R_{RCIN} of between 0.5MΩ and 2MΩ.

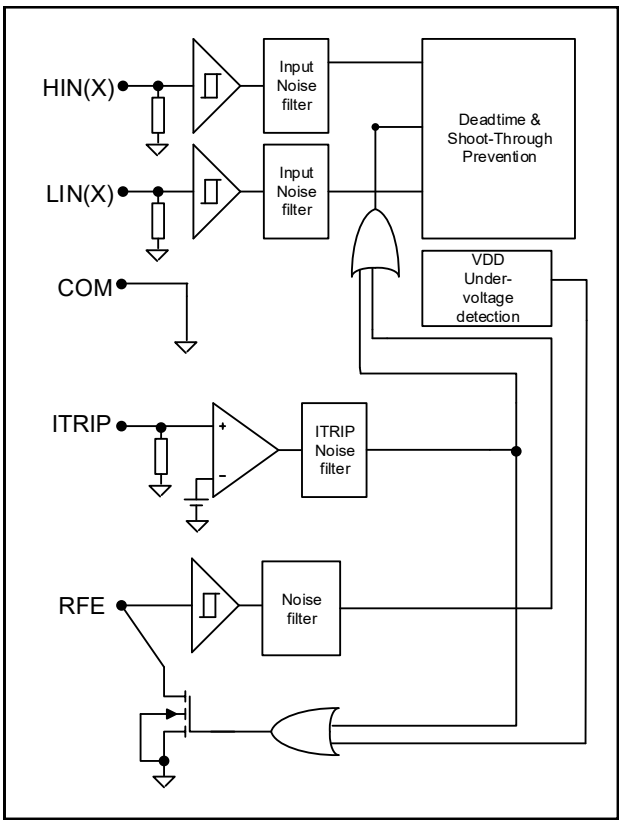


Figure 6 RFE internal circuit structure

V_{S1}, V_{S2}, V_{S3} (High side emitter and low side collector)

These pins are motor U, V, W input pins.

P (Positive bus input voltage)

The high side IGBTs are connected to the bus voltage. It is noted that the bus voltage does not exceed 450V.

3 Absolute Maximum Rating

3.1 Module

Table 3

Parameter	Symbol	Conditions	Value	Units
Operating junction temperature	T_J	IGBT, diode, HVIC	-40 ~ 150	°C
Operating case temperature	T_C		-40 ~ 125	°C
Storage temperature	T_{STG}		-40 ~ 125	°C
Isolation test voltage	V_{ISO}	AC RMS, 1 minute, 60Hz	2000	V

3.2 Inverter

Table 4

Parameter	Symbol	Conditions	Value	Units
Blocking voltage	V_{CES}	IGBT, diode, HVIC	600	V
DC –link supply voltage of P-N	V_{PN}	Applied between P and N	450	V
DC –link supply voltage (surge) of P-N	$V_{PN(surge)}$	Applied between P and N	500	V
Output current	I_O	T_C = 25°C, T_J < 150°C	±6	A
Peak output current	$I_{O(peak)}$	T_C = 25°C, T_J < 150°C, less than 1ms	±9	A
Power dispassion per IGBT	P_{tot}		18	W
Short Circuit withstand time	T_{SC}	T_J < 150°C, V_{DC} =360V, V_{GE} = 15V	3	µs

3.3 Control

Table 5

Parameter	Symbol	Conditions	Value	Units
Logic supply voltage	V_{DD}		-0.3 ~ 20	V
Input voltage	V_{IN}	LIN, HIN, ITRIP, RFE	-0.3 ~ 20	V
High side floating supply voltage	$V_{BS(U,V,W)}$		-0.3 ~ 20	V

4 Thermal Characteristics

Table 6

Parameter	Symbol	Conditions	Value			Units
			Min.	Typ.	Max.	
Single IGBT thermal resistance, junction-case	$R_{TH(J-C)}$	Low side W-phase IGBT (See Figure 8 for T_C measurement point)	-	5.8	6.8	°C/W
Single diode thermal resistance, junction-case	$R_{TH(J-C)D}$	Low side W-phase diode (See Figure 8 for T_C measurement point)	-	6.6	7.7	°C/W

5 Recommended Operating Conditions

For proper operation the device should be used within the recommended conditions. All voltages are absolute referenced to COM. The VS offset is tested with all supplies biased at 15V differential.

Table 7

Parameter	Symbol	Conditions	Value			Units
			Min.	Typ.	Max.	
Positive DC bus input voltage	V_{DC}		-	-	450	V
Low side control supply voltage	V_{DD}		13.5	15	16.5	V
High side floating supply voltage	V_{BS}		12.5	15	17.5	V
Input voltage	V_{IN}	LIN, HIN, ITRIP, RFE	0	-	5	V
PWM carrier frequency	F_{PWM}		-	20	-	kHz
Voltage between COM and N (including surge)	V_{COM}		-5	-	5	V
External dead time between HIN & LIN	DT		1	-	-	µs
Input pulse width	$PW_{IN(ON)}$ $PW_{IN(OFF)}$		1	-	-	µs

6 Static Parameters

6.1 Inverter

$V_{BIAS}(V_{DD}, V_{BS(U,V,W)})$=15V, T_J=25°C unless otherwise specified

Table 8

Parameter	Symbol	Conditions	Value			Units
			Min.	Typ.	Max.	
Collector-Emitter saturation voltage	$V_{CE(ON)}$	I_C = 3A	-	1.5	1.95	V
		I_C = 3A, T_J = 150°C	-	1.7	-	V
Collector-Emitter leakage current	I_{CES}	V_{IN} = 0V, V_{CE} = 600V	-	10	80	µA
		V_{IN} = 0V, V_{CE} = 600V, T_J=150°C	-	80	-	µA
Diode forward voltage drop	V_F	I_C = 3A	-	1.5	1.95	V
		I_C = 3A, T_J = 150°C	-	1.4	-	V

6.2 Control

$V_{BIAS}(V_{DD}, V_{BS(U,V,W)})$=15V, T_J=25°C, unless otherwise specified. The V_{IN} parameters are referenced to COM and are applicable to all six channels

Table 9

Parameter	Symbol	Conditions	Value			Units
			Min.	Typ.	Max.	
Logic “1” input voltage	$V_{IN,TH+}$	LIN, HIN, RFE	2.5	-	-	V
Logic “0” input voltage	$V_{IN,TH-}$	LIN, HIN, RFE	-	-	0.8	V
V_{DD}/V_{BS} supply undervoltage, positive going threshold	$V_{DD,UV+}$, $V_{BS,UV+}$		9.6	10.4	11.2	V
V_{DD}/V_{BS} supply undervoltage, negative going threshold	$V_{DD,UV-}$, $V_{BS,UV-}$		8.6	9.4	10.2	V
V_{DD}/V_{BS} supply undervoltage lock-out hysteresis	V_{DDUVH}, V_{BSUVH}		-	1	-	V
Quiescent V_{BS} supply current	I_{QBS}		-	-	150	µA
Quiescent V_{DD} supply current	I_{QDD}		-	-	3.2	mA
Offset supply leakage current	I_{LK}	V_S = 600V	-	-	50	µA
Input bias current for LIN, HIN	I_{IN+}	V_{IN} = 3.3V	-	825	1110	µA
Input bias current for RFE	$I_{IN,RFE+}$	V_{REF} = 3.3V	-	0	1	µA
Input bias current for ITRIP	I_{TRIP+}	V_{ITRIP} = 3.3V	-	4	16	µA
ITRIP threshold voltage	V_{ITRIP}		0.44	0.49	0.54	V

Static Parameters

Parameter	Symbol	Conditions	Value			Units
			Min.	Typ.	Max.	
ITRIP input hysteresis	$V_{ITRIP,HYS}$		-	0.07	-	V
Bootstrap resistance	R_{BS}		-	200	-	Ω
RFE low on resistance	R_{RFE}		-	50	100	Ω

7 Dynamic Parameters

7.1 Inverter

$V_{BIAS}(V_{DD}, V_{BS(U,V,W)})$=15V, T_J=25°C, unless otherwise specified.

Table 10

Parameter	Symbol	Conditions	Value			Units
			Min.	Typ.	Max.	
Input to output turn-on propagation delay	T_{ON}	I_C = 3A, V_{DC} = 300V	-	-	1.15	µs
Input to output turn-off propagation delay	T_{OFF}	I_C = 3A, V_{DC} = 300V	-	-	1.15	µs
RFE low to six switch turn-off propagation delay	T_{EN}	V_{RFE} = 5V to 0V	-	-	1.35	µs
ITRIP to six switch turn-off propagation delay	T_{ITRIP}	I_C = 3A, V_{DC} = 300V	-	-	1.5	µs
IGBT turn-on energy	E_{ON}	V_{DC} = 300V, I_C = 3A T_J = 25°C 150°C	- -	90 130	- -	µJ
IGBT turn-off energy	E_{OFF}	V_{DC} = 300V, I_C = 3A T_J = 25°C 150°C	- -	30 45	- -	µJ
Diode reverse recovery energy	E_{REC}	V_{DC} = 300V, I_C = 3A T_J = 25°C 150°C	- -	15 35	- -	µJ
Reverse Bias Safe Operating Area	RBSOA	T_J = 150°C, I_C = 12A, V_P = 600V, V_{DC} = 450V, V_{DD} = +15V to 0V	FULL SQUARE			

7.2 Control

$V_{BIAS}(V_{DD}, V_{BS(U,V,W)})$ = 15V, T_J = 25°C, unless otherwise specified.

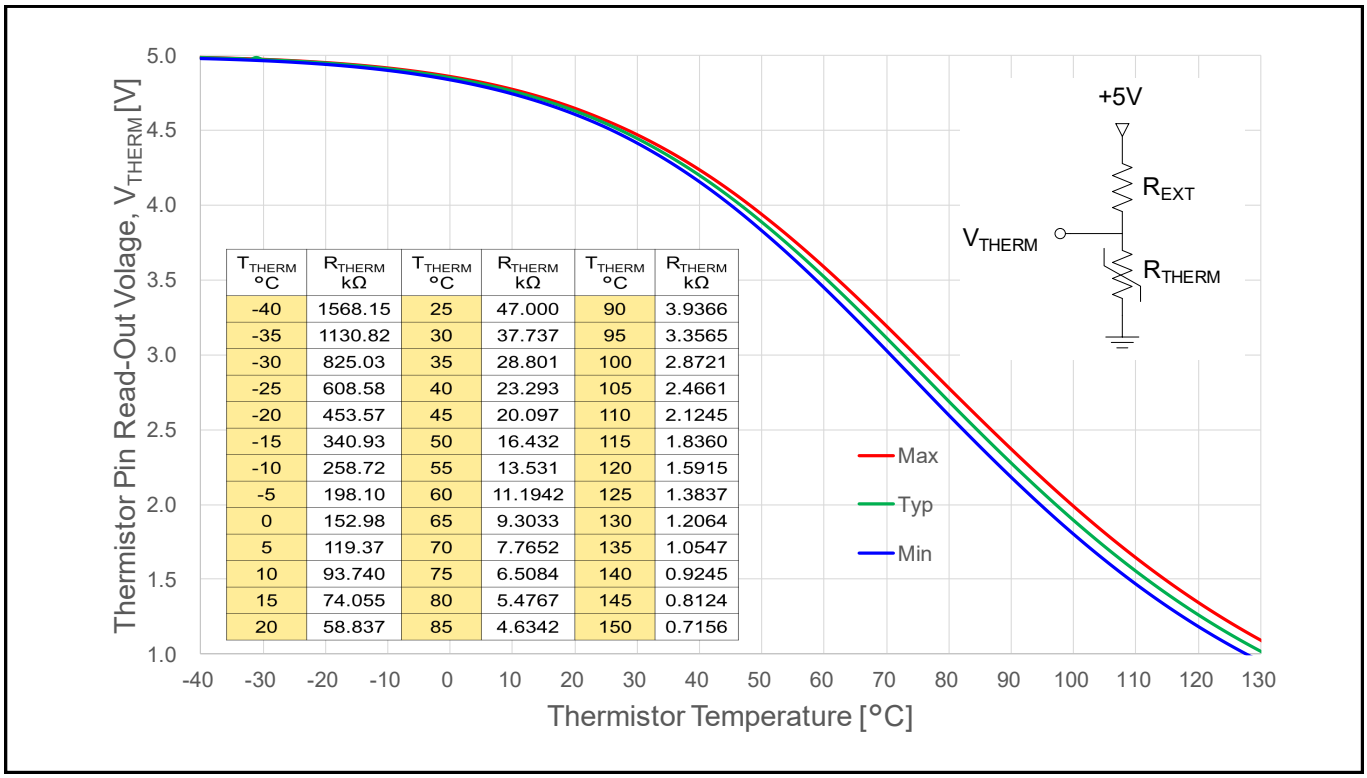
Table 11

Parameter	Symbol	Conditions	Value			Units
			Min.	Typ.	Max.	
Input filter time (HIN, LIN, ITRIP)	T_{FILIN}	V_{IN} = 0 or V_{IN} = 5V	-	350	-	ns
Input filter time (RFE)	T_{FILRFE}	V_{RFE} = 0 or V_{RFE} = 5V	100	200	-	ns
ITRIP to Fault propagation delay	T_{FLT}	V_{IN} = 0 or V_{IN} = 5V, V_{ITRIP} = 5V	400	600	800	ns
Internal injected dead time	T_{DT}	V_{IN} = 0 or V_{IN} = 5V	190	275	420	ns
Matching propagation delay time (On & Off) all channels	M_T	External dead time > 420ns	-	-	50	ns

8 Thermistor Characteristics

Table 12

Parameter	Symbol	Conditions	Value			Units
			Min.	Typ.	Max.	
Resistance	R_{25}	T = 25°C, ±5% tolerance	44.65	47	49.35	kΩ
Resistance	R_{125}	T = 125°C	1.27	1.41	1.56	kΩ
B-constant	B	25-50°C, $R_2=R_1e^{[B1/T2-1/T1)]}$	3989	4050	4111	K
Temperature Range			-40	-	125	°C



T_{THERM} °C	R_{THERM} kΩ	T_{THERM} °C	R_{THERM} kΩ	T_{THERM} °C	R_{THERM} kΩ
-40	1568.15	25	47.000	90	3.9366
-35	1130.82	30	37.737	95	3.3565
-30	825.03	35	28.801	100	2.8721
-25	608.58	40	23.293	105	2.4661
-20	453.57	45	20.097	110	2.1245
-15	340.93	50	16.432	115	1.8360
-10	258.72	55	13.531	120	1.5915
-5	198.10	60	11.1942	125	1.3837
0	152.98	65	9.3033	130	1.2064
5	119.37	70	7.7652	135	1.0547
10	93.740	75	6.5084	140	0.9245
15	74.055	80	5.4767	145	0.8124
20	58.837	85	4.6342	150	0.7156

Figure 7 **Thermistor readout vs. temperature (with 4.7kohm R_{EXT} pull-up resistor) and typical thermistor resistance values vs. temperature table (For more details, please refer to the application note 'AN2018-13 CIPOS™ IM393-XX IPM technical description_1R0_final')**

9 Mechanical Characteristics and Ratings

Table 13

Parameter	Symbol	Conditions	Value			Units
			Min.	Typ.	Max.	
Thermal resistance, case-heatsink	$R_{TH(C-S)}$	Flat, greased surface. Heatsink compound thermal conductivity 1W/mK	-	0.25	-	°C/W
Comparative Tracking Index	CTI		600	-	-	V
Curvature of module backside	BKC		0	-	150	µm
Mounting torque	T	M3 screw and washer	0.6	0.7	0.8	Nm
Weight	W		-	5.8	-	g

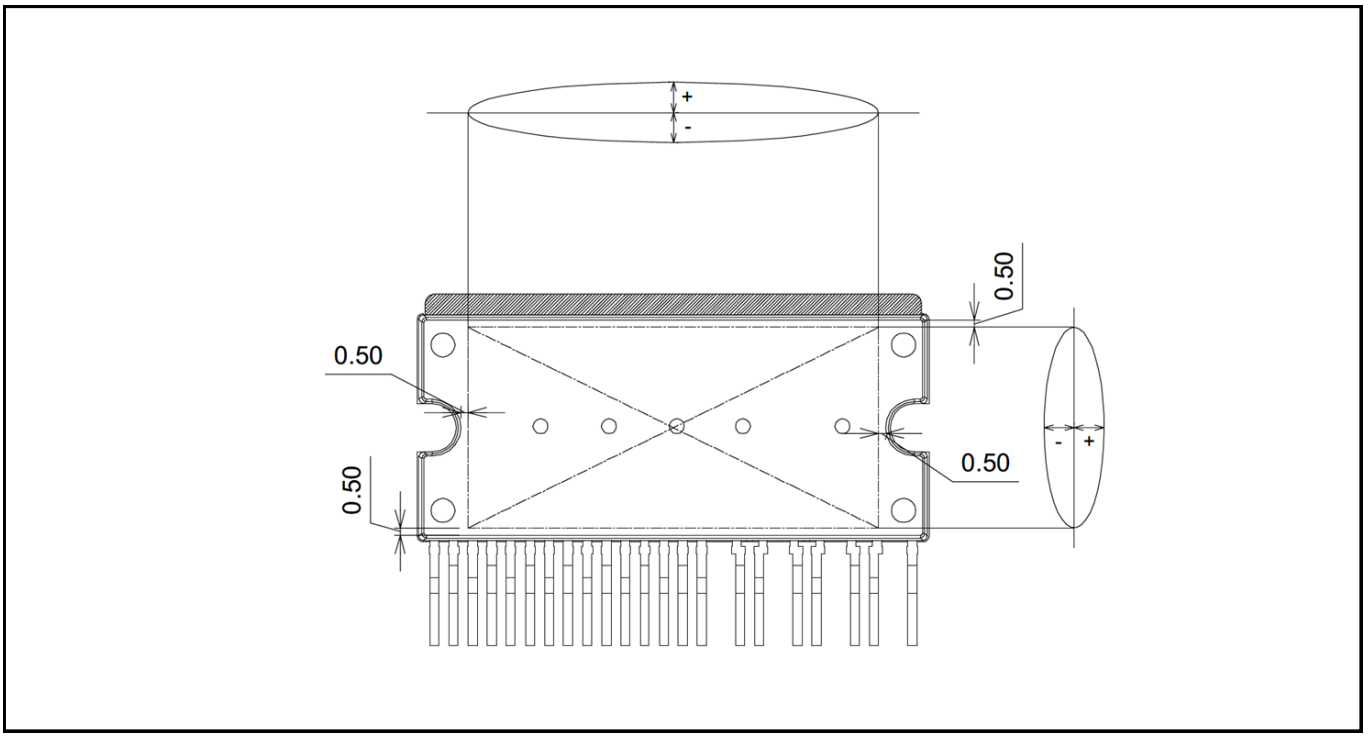


Figure 8 Backside curvature measurement position

10 Qualification Information

Table 14

UL Certified	File Number : E314539	
RoHS Compliant	Yes	
ESD	Human body model class	2
	Charged device model class	C2a

11 Diagram & Tables

11.1 Tc Measurement Point

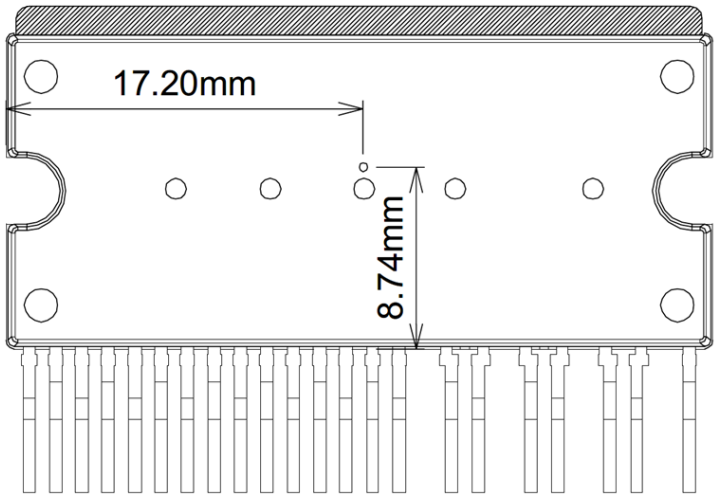


Figure 9 TC measurement point

11.2 Input-Output Logic Table

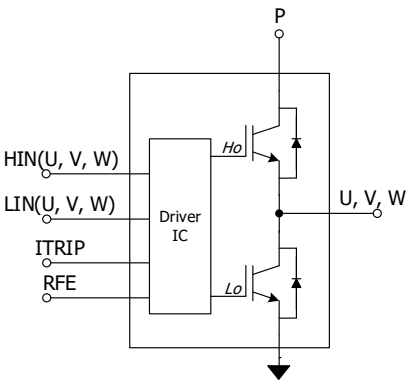


Figure 10 Module block diagram

Table 15 Input-output logic level table

RFE	ITRIP	HIN(U,V,W)	LIN(U,V,W)	U,V,W
1	0	1	0	V_{DC}
1	0	0	1	0
1	0	0	0	Off*
1	0	1	1	Off*
1	1	X	X	Off*
0	X	X	X	Off*

* Voltage depends on direction of phase current

11.3 Switching Time Definitions

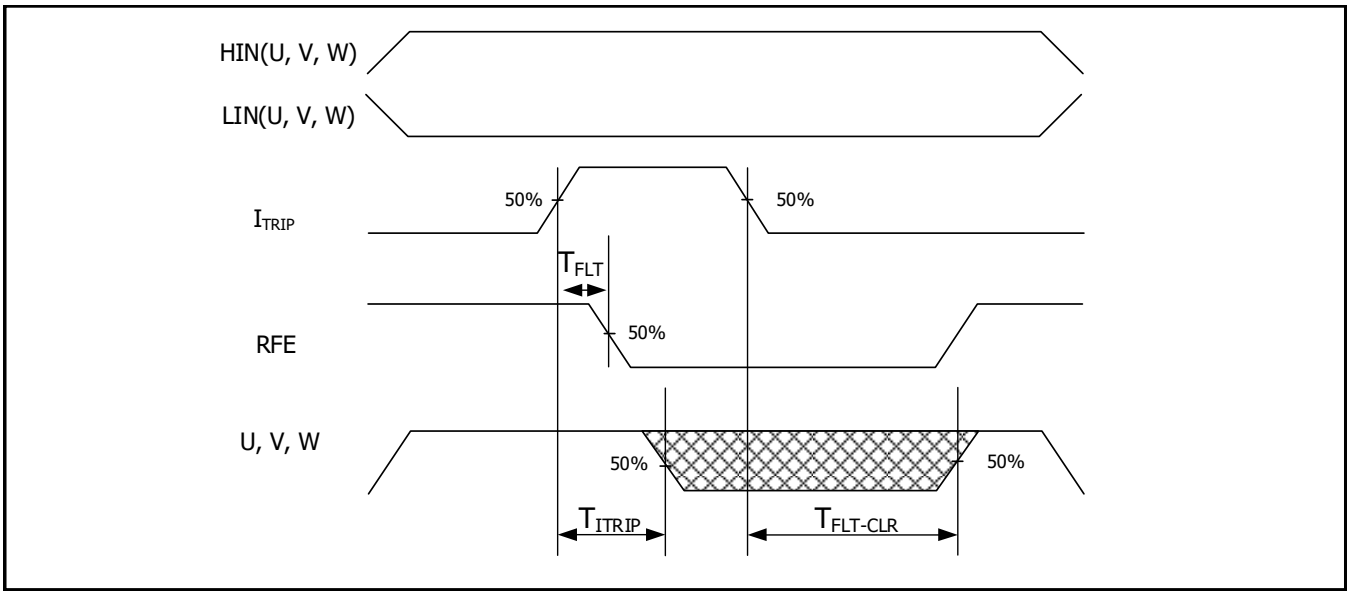


Figure 11 ITRIP time waveform

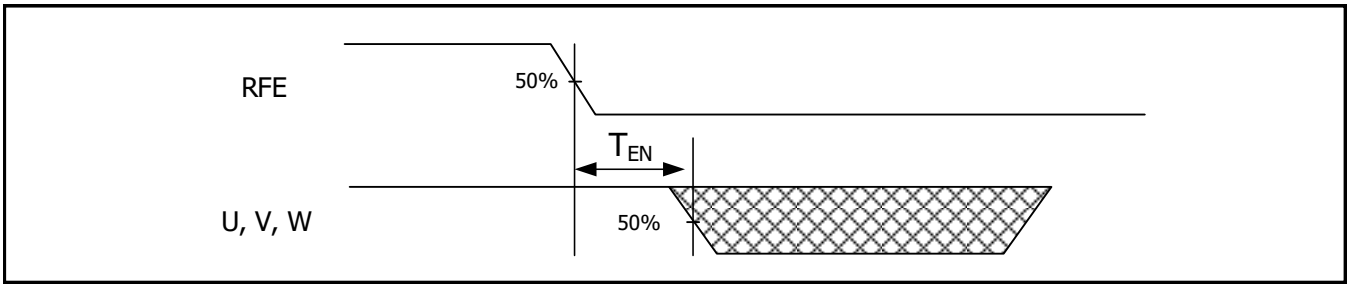


Figure 12 Output disable timing diagram

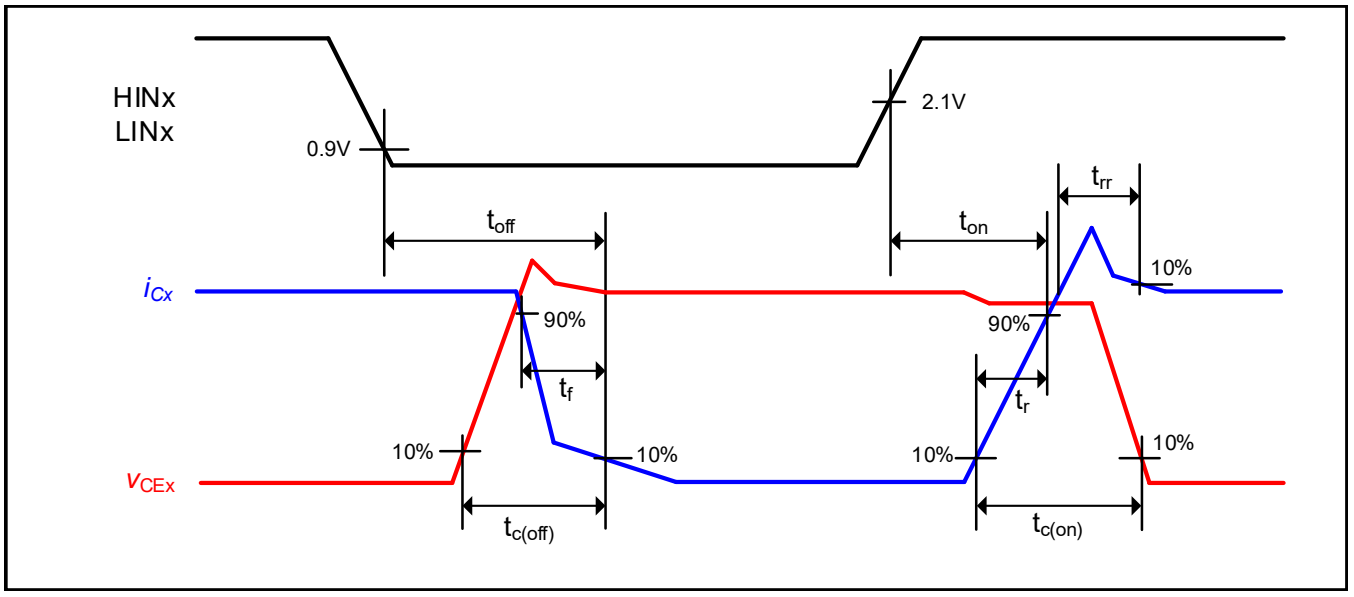


Figure 13 Switching times definition

12 Application Guide

12.1 Typical Application Schematic

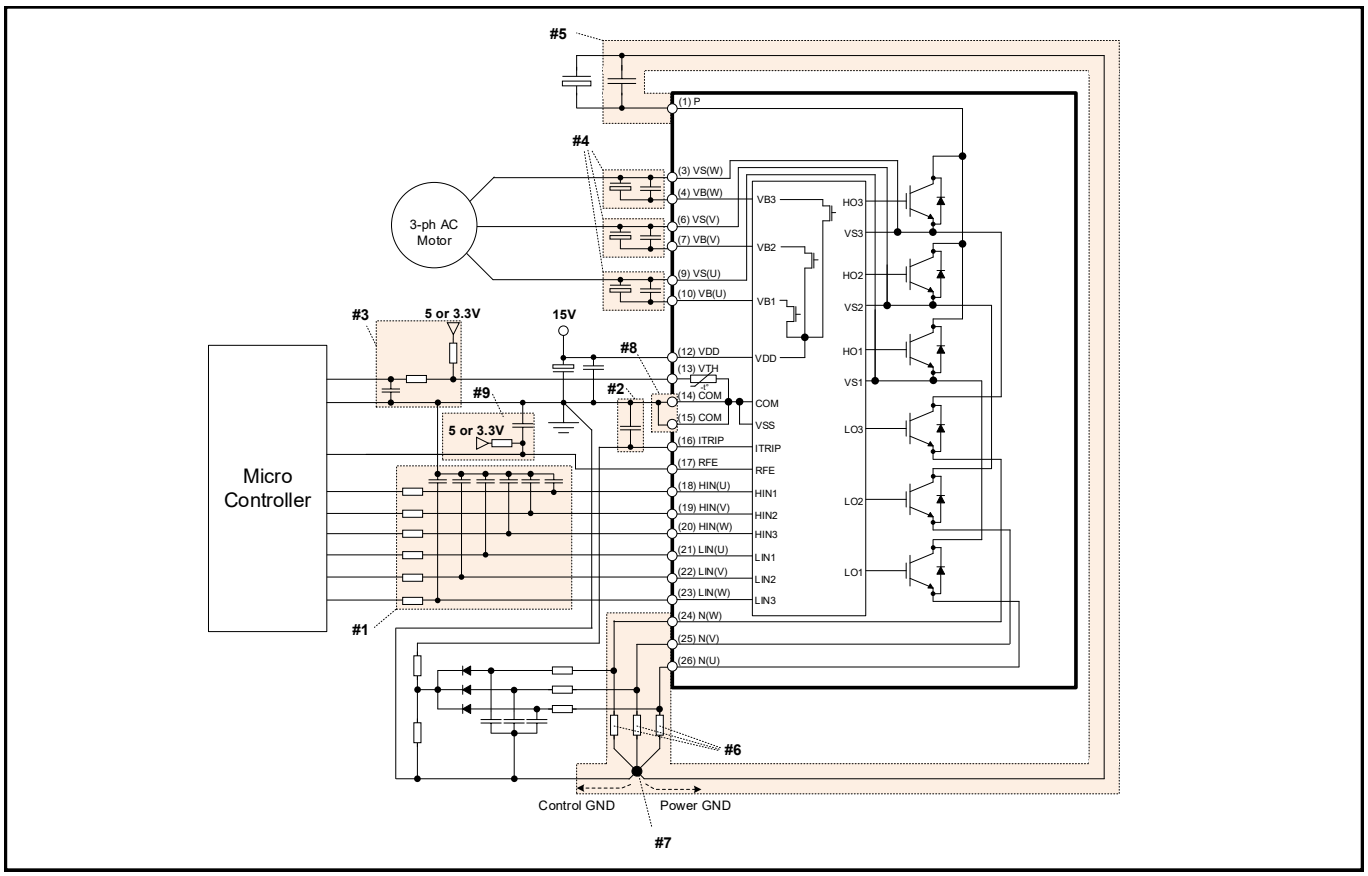


Figure 14 Typical application connection

1. Input circuit
   -RC filter can be used to reduce input signal noise (100Ω, 1nF)
   -The capacitors should be located close to CIPOS™ Tiny (to COM terminal especially).
2. Itrip circuit
   -To prevent a mis operation of protection function, RC filter is recommended
   -The capacitor must be located close to Itrip and COM terminals.
3. VTH circuit
   -This terminal should be pulled up to the bias voltage of 5V/3.3V through a proper resistor to define suitable voltage for temperature monitoring.
   -It is recommended that RC filter is placed close to the controller
4. VB-VS circuit
   -Capacitors for high side floating supply voltage should be placed close to VB and VS terminals.
   -Additional high frequency capacitors, typically 0.1µF, are strongly recommended.
   -Overlap of pattern to motor and pattern to bootstrap capacitors should be minimized.
5. Snubber capacitor
   -The wiring among CIPOS™ Tiny, snubber capacitor and shunt resistors should be short as possible.
6. Shunt resistor
   -SMD type shunt resistors are strongly recommended to minimize its internal stray inductance.
7. Ground pattern
   -Pattern overlap of power ground and signal ground should be minimized. The patterns should be connected at the common end of shunt resistors only for the same potential.
8. COM pattern
   -Both of the COM terminals should be connected together.
9. RFE circuit
   -To setup R and C parameter for fault clear time, please refer to Figure 5.
   -This R is also mandatory for fault out reporting function because it is open drain structure.

12.2 Performance Charts

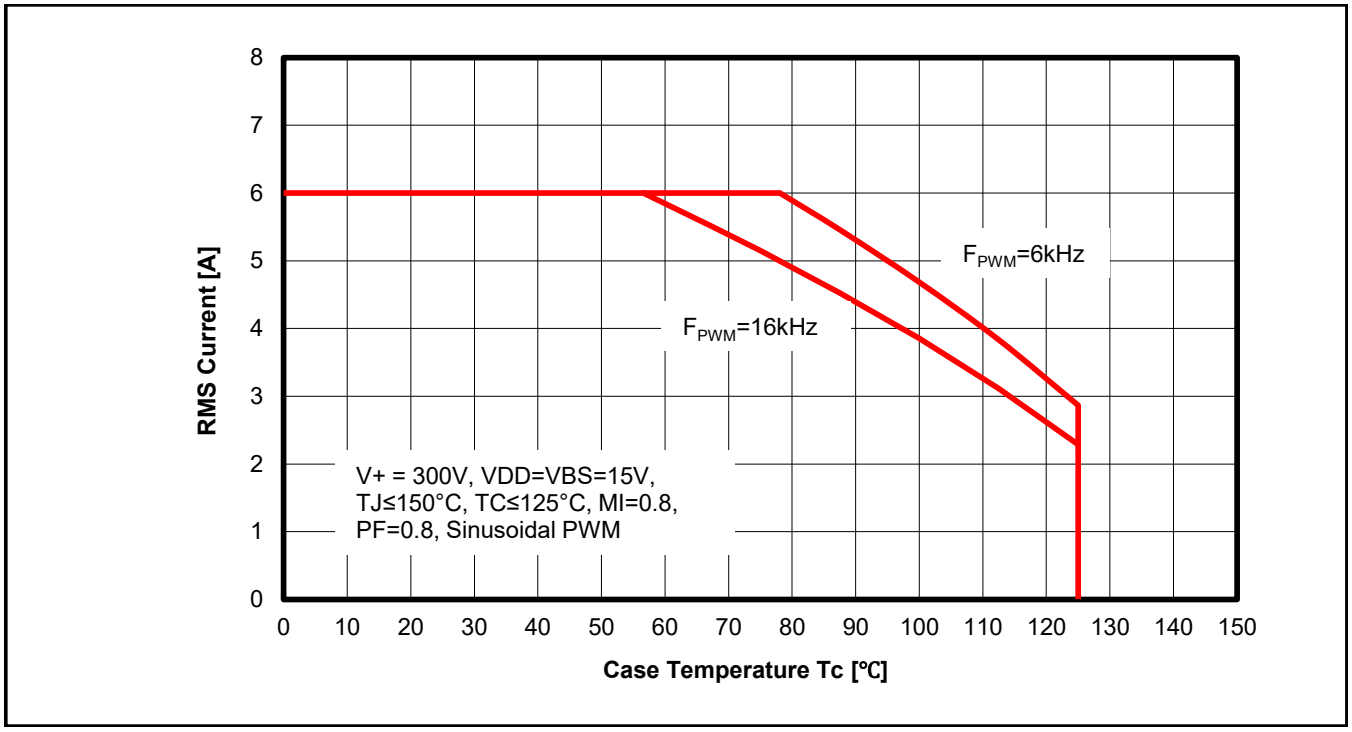


Figure 15 Maximum operating current SOA

1. This maximum operating current SOA is just one of example based on typical characteristics for this product. It can be change by each user's actual operating conditions.

12.3 Tj vs. Tth

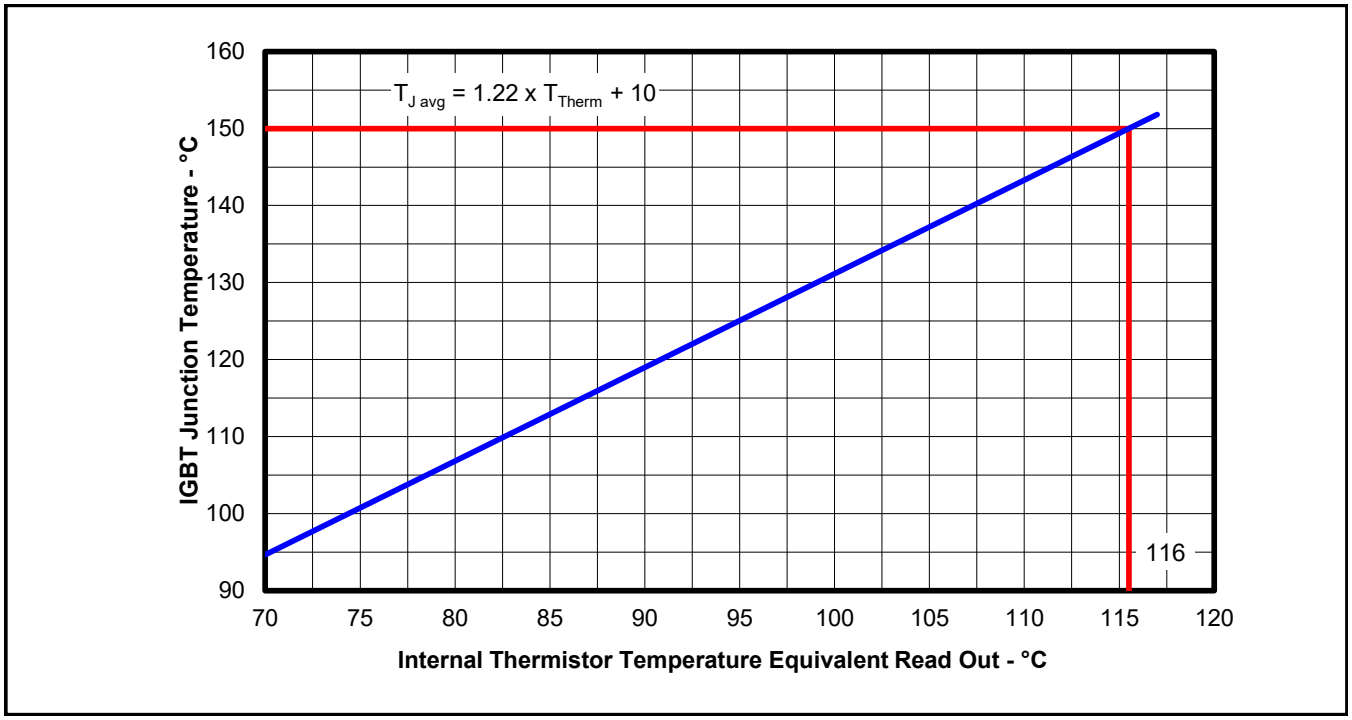


Figure 16 Typical Tj vs Tth correlation, sinusoidal modulation, V_{DC}=300V, Iphase=5Arms, fsw=16kHz, fmod=50Hz, MI=0.8, PF=0.6

12.4 $-V_S$ Immunity

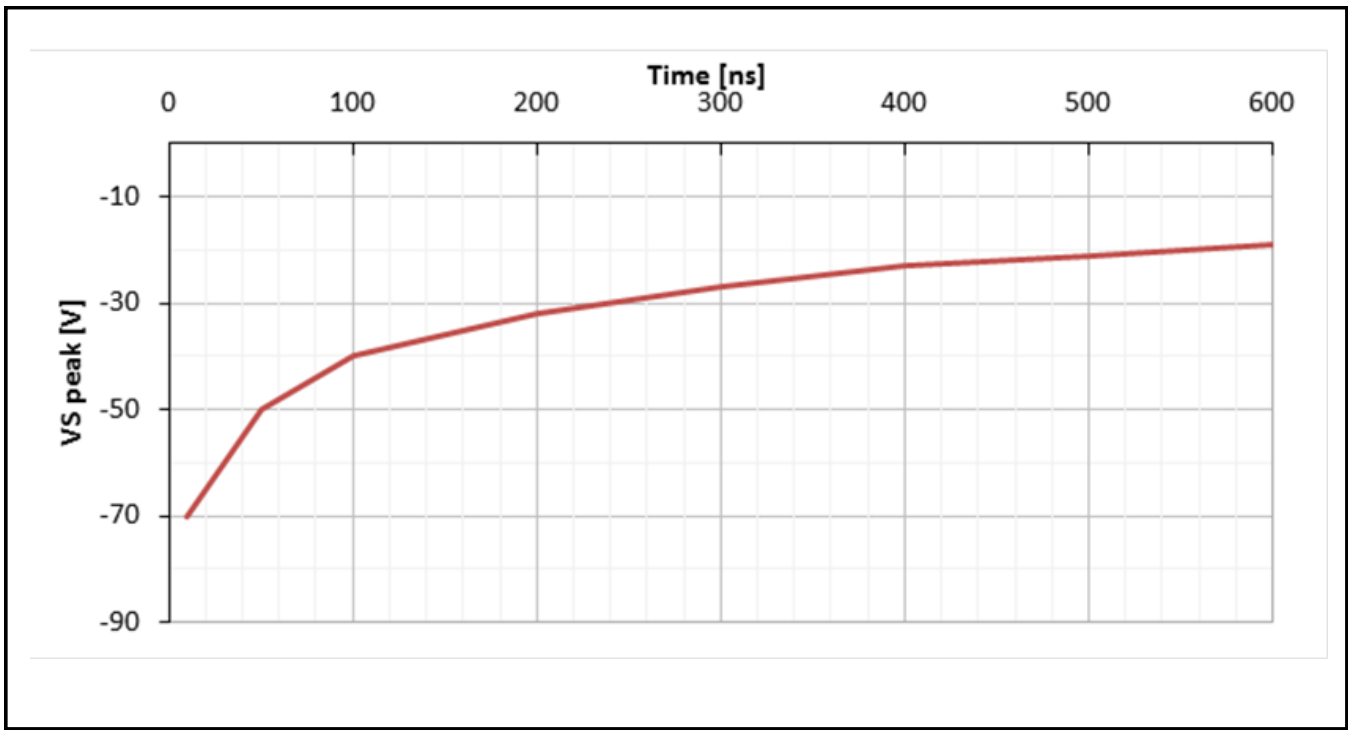


Figure 17 Negative transient Vs SOA for integrated gate driver

13 Package Outline

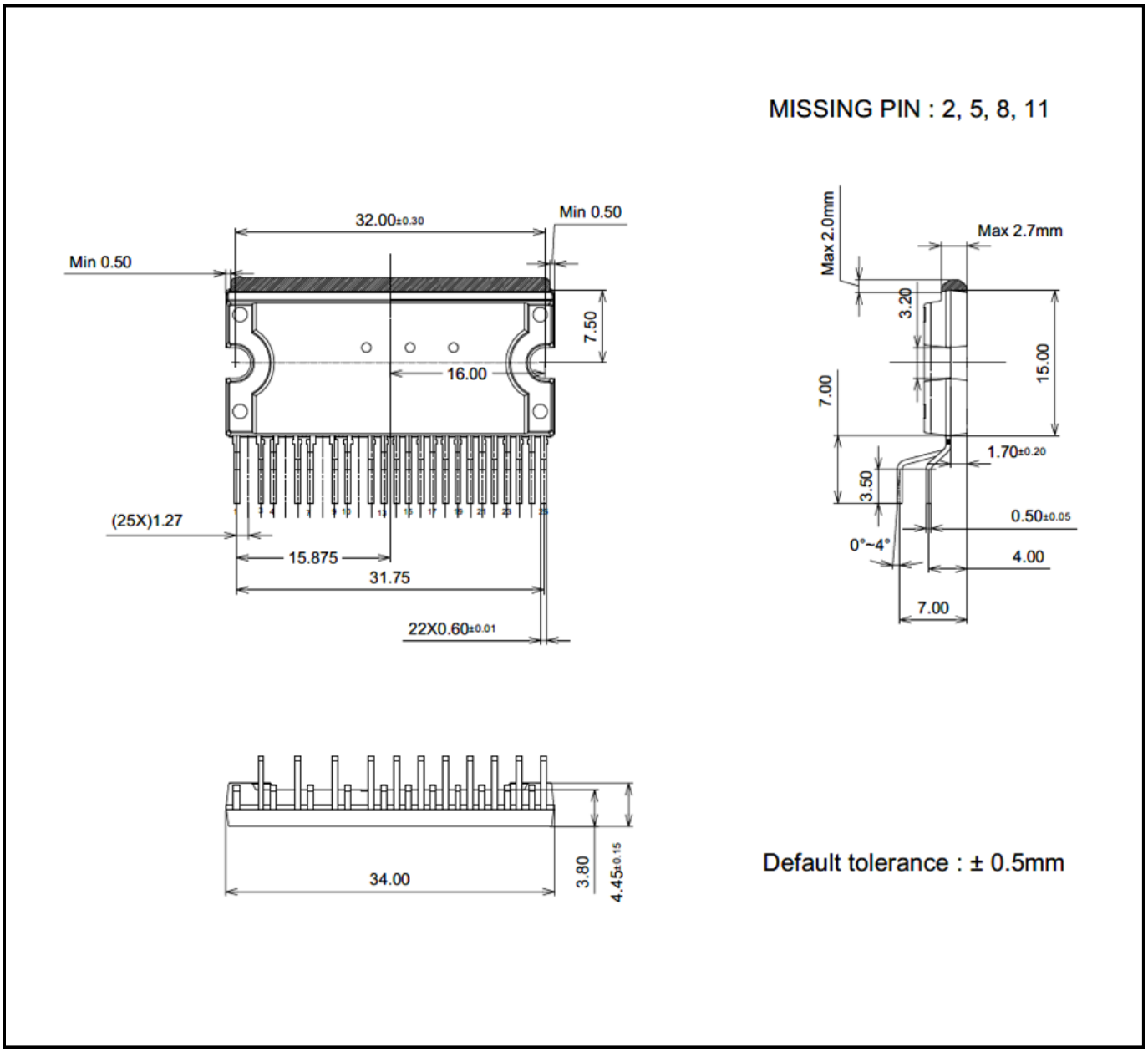


Figure 18 IM393-S6FP

Revision History

Major changes since the last revision

Page or Reference	Revision	Date	Description of changes
Page 16	V2.1	2022-08-16	ESD class changed

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